Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/781,812	CHAN ET AL.
Examiner	Art Unit
DON N VO	2011

SEARCHED				
Class	Subclass	Date	Examiner	
UPDATED		9/4/2007	DV	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	297	9/4/2007	DV	

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